

Application/Control No.	Applicant(s)/Patent under Reexamination
09/819,211	NEUBAUER ET AL.
Examiner	Art Unit
Charles Kim	2623

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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
search updated-see search history report. Note: A portion of the search history report was lost due to a power outage.	8/4/2005	ск		
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